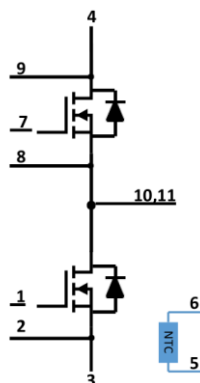


Product Summary

Product Type	V _{DSS}	I _D	R _{DS(on)}	Package
ATSCM2R5N170HBMW	1700V	800A	2.5mΩ	EcoDual 3



Features

- 1700V SiC MOSFET Power Module
- Very Low R_{DS(on)}
- Very low switching loss
- EcoDual 3 half bridge module
- Halogen Free, RoHS compliant

Typical Applications

- Motor drive
- Servo drive
- UPS / Solar
- Energy storage system

Maximum Ratings (SiC MOSFET, T_j=25°C unless otherwise specified)

Parameter	Symbol	Conditions	Value	Unit
Drain-Source Voltage	V _{DSS}		1700	V
Gate-Source Voltage	V _{GSS}		-8/+22	V
Drain Current	I _D	T _C =25°C T _C =100°C	890 625	A
Pulse Drain Current	I _{DM}		1800	A
Maximum Power Dissipation	P _D	T _C =25°C, T _j =150°C	3900	W
Operation junction temperature	T _{vj-op}		-55 to175	°C
Storage temperature	T _{stg}		-55 to 150	°C

Maximum Ratings (diode, $T_j = 25^\circ\text{C}$ unless otherwise specified)

Parameter	Symbol	Conditions	Value	Unit
Body diode current	I_S	$T_C = 25^\circ\text{C}$, $V_{GS} = -4\text{V}$	800	A
Pulse source current	I_{SM}	verified by design, t_p limited by T_{vjmax}	1800	A

Module information

Parameter	Conditions	Value	Unit
Isolation Voltage	RMS, $f = 50\text{Hz}$, $t = 1\text{min}$	4	KV
Mounting torque for module mounting	M5, M6	3 to 5	Nm
Weight of Module	G	340	g
Junction to case (MOSFET)	$R_{th(j-c)}$	0.04 max	K/W
Case to heatsink (MOSFET)	R_{thCH}	0.02 typ.	K/W
Case to heatsink (per module)		0.01 typ.	

MOSFET Electrical characteristics ($T_j = 25^\circ\text{C}$ unless otherwise specified, chip)

Parameter	Symbol	conditions		Min	Typ	Max	Unit
Drain to source breakdown voltage	V _{(BR)DSS}	V _{GS} =0V, I _D =100uA		1700			V
Static Drain-Source On-Resistance	R _{DS(on)}	I _D =600A, V _{GS} =18V	T _J =25 °C		2.5	3.3	mΩ
			T _J =175 °C		4.4		mΩ
Gate-Source threshold Voltage	V _{GS(th)}	I _D =240mA, V _{DS} =V _{GS}	T _J =25 °C	2.3	3.3	4.0	V
			T _J =175 °C		2.5		
Gate charge	Q _G	V _{DS} =1200V, V _{GS} =-4/+18V I _D =600A			1680		nC
Internal gate resistor	R _{Gint}	V _{AC} =25mV, f=1MHz	T _J =25 °C		1.6		Ω
Input Capacitance	C _{iss}	V _{GS} =0V,	T _J =25 °C		42		nF
Output Capacitance	C _{oss}	V _{DS} =1400V			1500		pF
Reverse transfer Capacitance	C _{rss}	f =100KHz			61		pF
Drain-Source leakage Current	I _{DSS}	V _{DS} =1700V, V _{GS} =0V	T _J =25 °C			30	uA
Gate-Source Leakage Current	I _{GSS}	V _{GS} =18V V _{DS} =0V	T _J =25 °C			100	nA
Turn-on delay time	t _{d(on)}	V _{DS} =1200V	T _J =25 °C				ns
Rise time	t _r	I _D = 600A	T _J =25 °C				ns
Turn-off delay time	t _{d(off)}	V _{GS} =-4V/18V	T _J =25 °C				ns
Fall time	t _f	R _G =2.5Ω	T _J =25 °C				ns
Turn-on switch loss	E _{on}	L=16.7uH	T _J =25 °C				mJ
Turn-off switch loss	E _{off}		T _J =25 °C				mJ

Diode Electrical characteristics (T_j =25°C unless otherwise specified, chip)

Item	Symbol	Condition	Min.	Typ.	Max.	Unit
Diode Forward Voltage	V _{SD}	I _S =400A, V _{GS} =-4V	T _j =25 °C	4.0		V
			T _j =175 °C	3.5		V
Peak reverse recovery Current	I _{rr}	V _{rr} =1200V, I _F =600A V _{GS} =-4V	T _j =175 °C			A
Diodes reverse recovery time	trr		T _j =175 °C			ns
Recovered charge	Q _{rr}		T _j =175 °C			uC

NTC characteristics

Item	Symbol	Condition	Min.	Typ.	Max.	Unit
Rated Resistance	R ₂₅	T _c =25 °C		5.0		KΩ
Deviation for R100	△R/R	T _c =25 °C, R ₁₀₀ =493Ω	-5		5	%
Power dissipation	P ₂₅	T _c =25 °C		20		mW
B value	B _{25/50}	R ₂ =R ₂₅ exp[B 25/50 (1/T2-1/(298,15K))]		3375		K

Characteristics graphs:

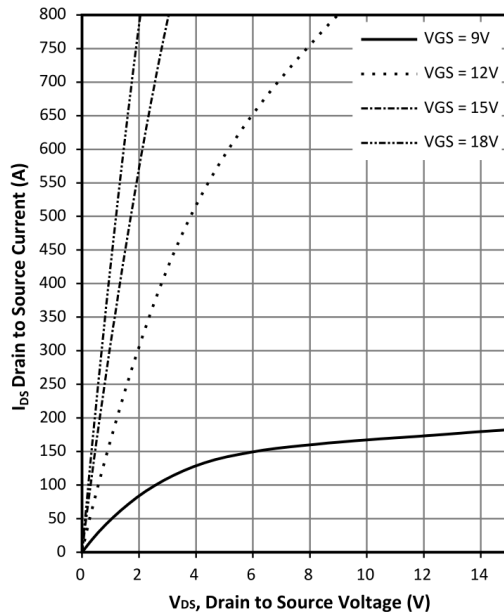


Fig 1: Typical output characteristics, MOSFET

$$I_D = f(V_{DS}), t_p < 200 \mu s, T_j = -55^\circ C$$

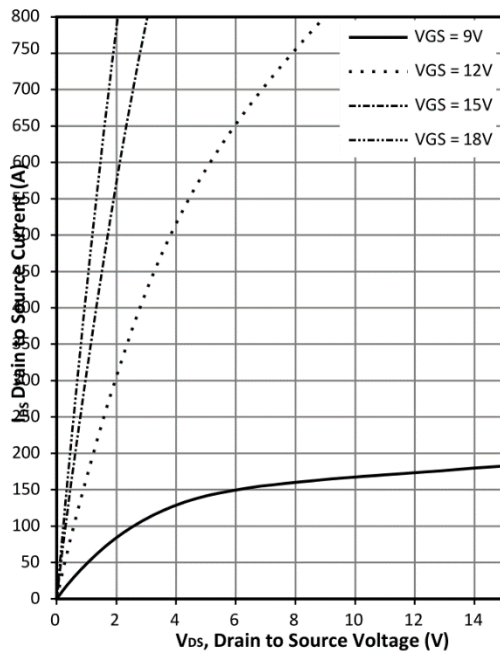


Fig 3: Typical output characteristics, MOSFET

$$I_D = f(V_{DS}), t_p < 200 \mu s, T_j = 175^\circ C$$

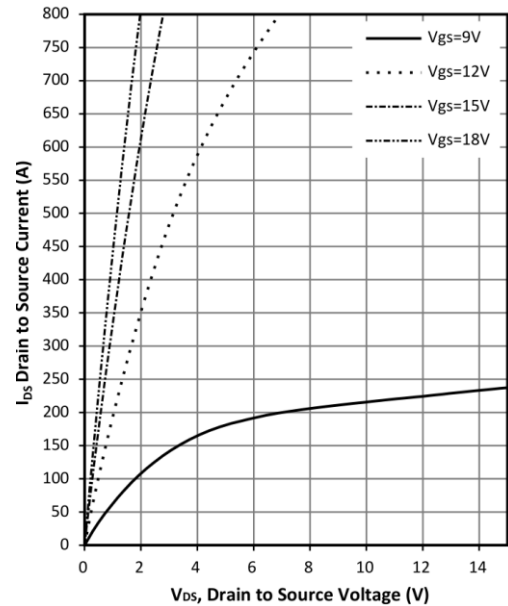


Fig 2: Typical output characteristics, MOSFET

$$I_D = f(V_{DS}), t_p < 200 \mu s, T_j = 25^\circ C$$

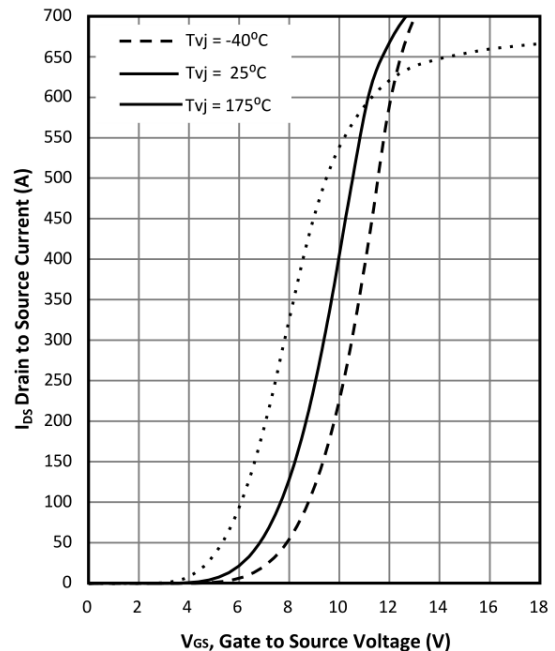


Fig 4: Transfer characteristics versus temperature

$$I_D = f(V_{DS}), t_p < 200 \mu s, V_{DS} = 20V$$

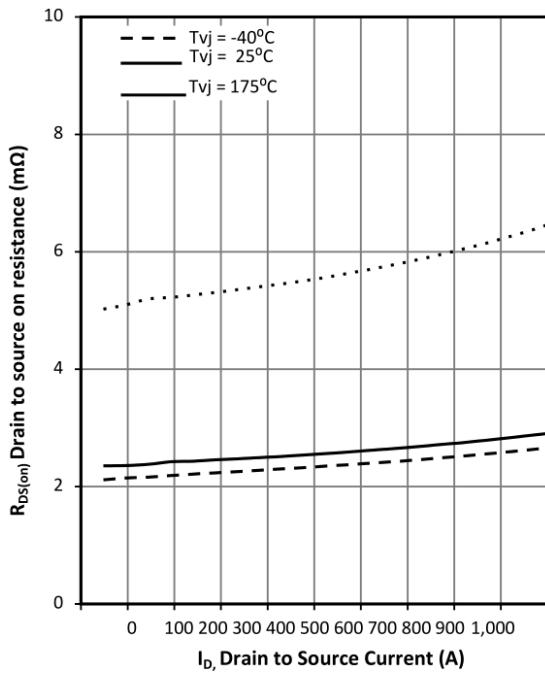


Fig 5: $R_{DS(on)}$ vs Drain current vs Temperature

$$R_{DS(on)} = f(I_D), t_p < 200 \mu\text{s}, V_{GS} = 18\text{V}$$

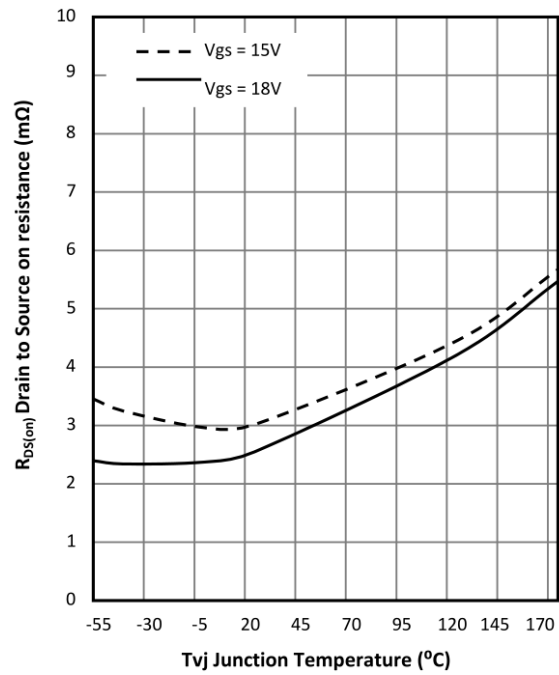


Fig 6: $R_{DS(on)}$ vs gate voltage vs Temperature

$$R_{DS(on)} = f(T_j), I_D = 600\text{A}, V_{GS} = 18\text{V}$$

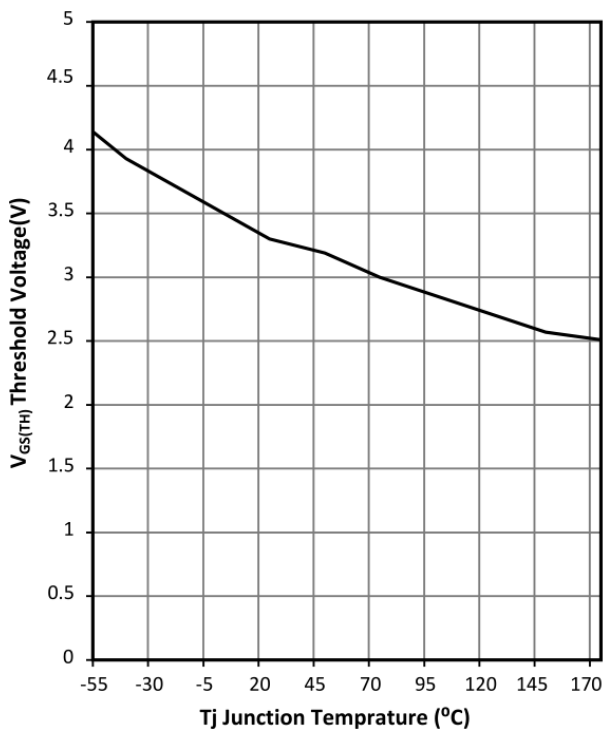


Fig 7: Threshold voltage vs Temperature

$$V_{GS} = V_{DS}, t_p < 200 \mu\text{s}, I_D = 240\text{mA}$$

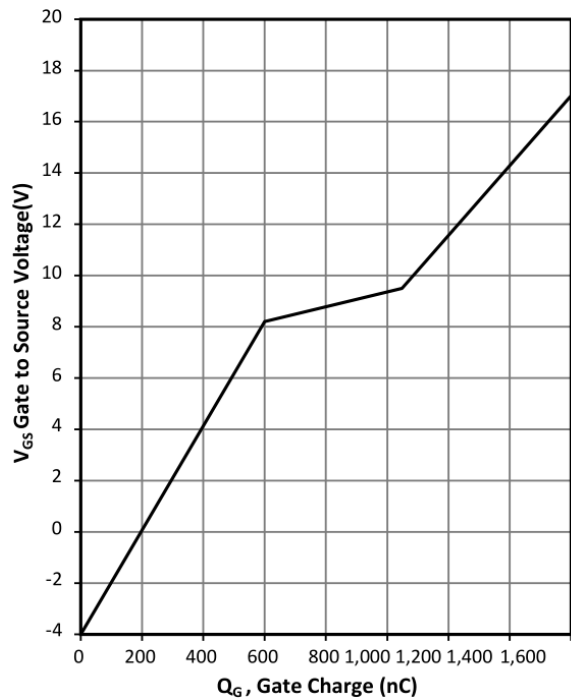


Fig 8: Gate characteristic

$$V_{DS} = 1200\text{V}, t_p < 200 \mu\text{s}, I_D = 600\text{A}, T_j = 25^\circ\text{C}$$

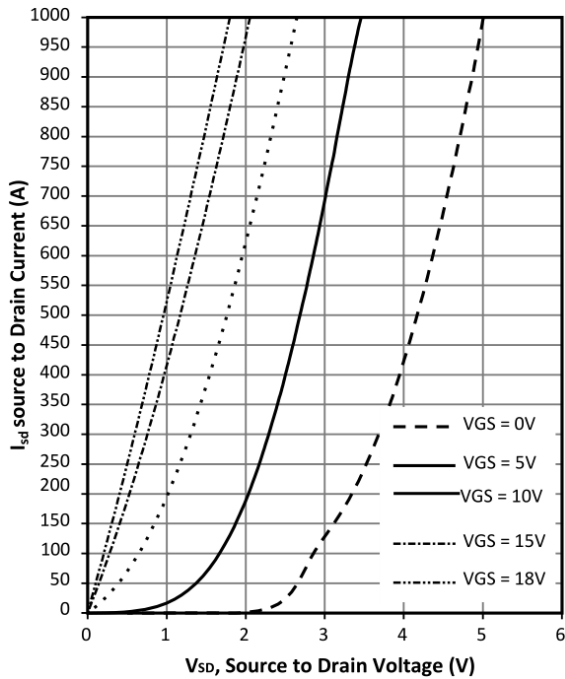


Fig 9: Reverse conduct characteristic @ different V_{GS}

$$I_S = f(V_{SD}), t_p < 200 \mu s, T_J = -55^\circ C$$

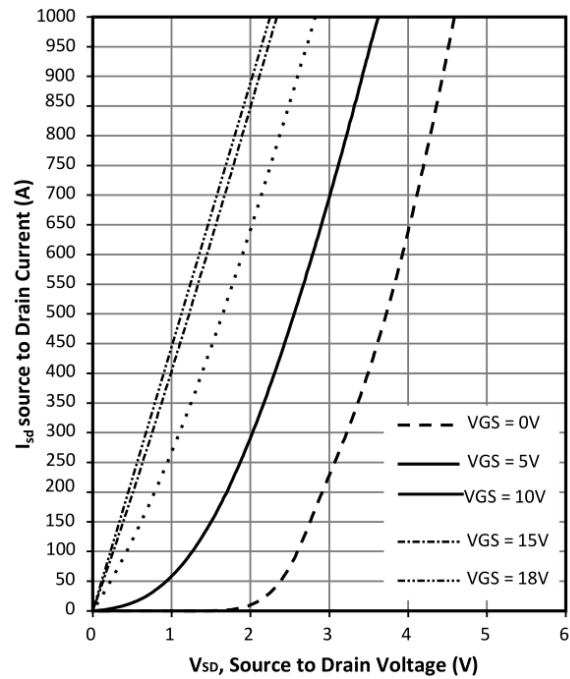


Fig 10: Reverse conduct characteristic @ different V_{GS}

$$I_S = f(V_{SD}), t_p < 200 \mu s, T_J = 25^\circ C$$

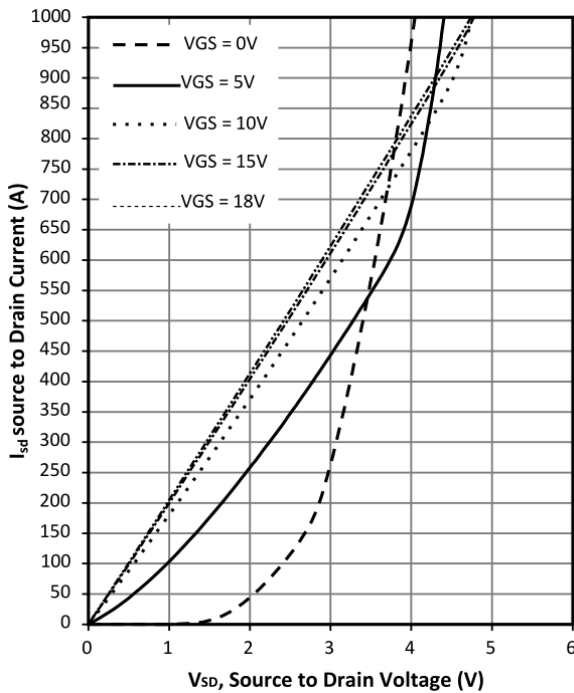


Fig 11: Reverse conduct characteristic @ different V_{GS}

$$I_S = f(V_{SD}), t_p < 200 \mu s, T_J = 175^\circ C$$

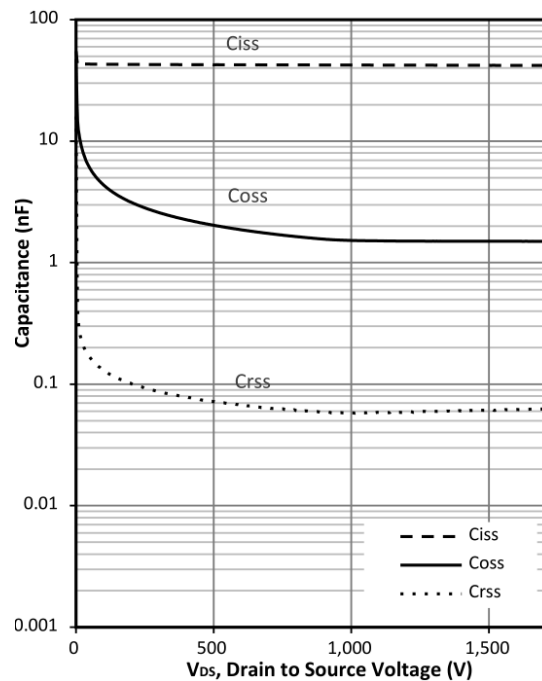


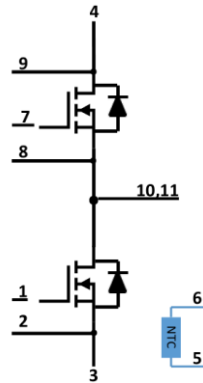
Fig 12: Capacitance vs drain source voltage

$$V_{AC} = 25 mV, f = 100 kHz, T_J = 25^\circ C$$

Package Information:

Circuit diagram

EcoDual 3



Dimensions in Millimeters

